

**Search Notes**

Application/Control No.

10/624,765

Examiner

Shengjun Wang

Applicant(s)/Patent under  
Reexamination

MEYERS ET AL.

Art Unit

1617

**SEARCHED**

Class	Subclass	Date	Examiner
514	570	10/22/2007	SW

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR